# MSCSM120SKM11CT3AG Datasheet Buck Chopper SiC MOSFET Power Module

January 2020





# **Contents**

Revision History	1
Revision 1.0	1
Product overview	2
2.1 Features	3
2.2 Benefits	3
2.3 Applications	3
Electrical Specifications	4
3.1 SiC MOSFET Characteristics (Per MOSFET)	4
3.2 SiC Scottky Diode Ratings and Characteristics	6
3.3 Thermal and Package Characteristics	6
3.4 Typical SiC MOSFET Performance Curves	8
3.5 Typical SiC Diode Performance Curves	11
Package Specifications	12
4.1 Package Outline Drawing	12



# 1 Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

#### 1.1 Revision 1.0

Revision 1.0 was published in January 2020. It is the first publication of this document.



## 2 Product Overview

The MSCSM120SKM11CT3AG device is a buck chopper 1200 V/254 A full Silicon Carbide (SiC) power module.

Figure 1 • MSCSM120SKM11CT3AG Electrical Schematic

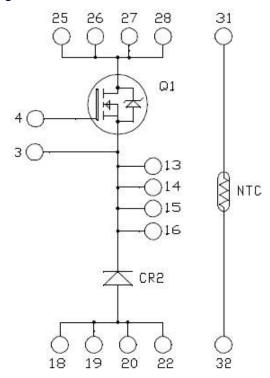
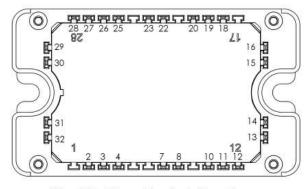


Figure 2 • MSCSM120SKM11CT3AG Pinout Location



Pins 25 to 28 must be shorted together Pins 13 to 16 must be shorted together Pins 18/19/20/22 must be shorted together

All ratings at  $T_1 = 25$  °C, unless otherwise specified.

**Caution**: These devices are sensitive to electrostatic discharge. Proper handling procedures should be followed.



#### 2.1 Features

The following are key features of the MSCSM120SKM11CT3AG device:

- SiC Power MOSFET
  - High speed switching
  - Ultra low loss
  - Low R<sub>DS(on)</sub>
- SiC Schottky Diode
  - Zero reverse recovery
  - Zero forward recovery
  - Temperature independent switching behavior
  - Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- · Internal thermistor for temperature monitoring
- Aluminum nitride (AIN) substrate for improved thermal performance

#### 2.2 Benefits

The following are benefits of the MSCSM120SKM11CT3AG device:

- High efficiency converter
- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction-to-case thermal resistance
- Solderable terminals for power and signal, for easy PCB mounting
- Low profile
- · RoHS compliant

#### 2.3 Applications

The MSCSM120SKM11CT3AG device is designed for the following applications:

- Uninterruptible power supplies
- Induction heating and welding
- Solar inverter



# **3** Electrical Specifications

This section shows the electrical specifications of the MSCSM120SKM11CT3AG device.

## 3.1 SiC MOSFET Characteristics (Per MOSFET)

The following table shows the absolute maximum ratings per MOSFET of the MSCSM120SKM11CT3AG device.

**Table 1 • Absolute Maximum Ratings** 

Symbol	Parameter			Unit
V <sub>DSS</sub>	Drain-source voltage			
I <sub>D</sub>	Continuous drain current	T <sub>C</sub> = 25 °C	254 <sup>1</sup>	Α
		T <sub>C</sub> = 80 °C		
I <sub>DM</sub>	Pulsed drain current			
V <sub>GS</sub>	Gate-source voltage			V
R <sub>DSon</sub>	Drain source ON resistance			mΩ
P <sub>D</sub>	Power dissipation	T <sub>C</sub> = 25 °C	1067	w

#### Note:

**1.** Specification of SiC MOSFET device, but output current must be limited due to size of power connectors.

The following table shows the electrical characteristics per MOSFET of the MSCSM120SKM11CT3AG device.

**Table 2 • Electrical Characteristics** 

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>DSS</sub>	Zero gate voltage drain current	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 1200 V			30	300	μΑ
R <sub>DS(on)</sub>	Drain-source on resistance	V <sub>GS</sub> = 20 V	T <sub>J</sub> = 25 °C		8.4	10.4	mΩ
		I <sub>D</sub> = 120 A	T <sub>J</sub> = 175 °C		13.4		
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{GS} = V_{DS}$ , $I_D = 3 \text{ mA}$		1.8	2.8		V
I <sub>GSS</sub>	Gate-source leakage current	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V				300	nA



The following table shows the dynamic characteristics per MOSFET of the MSCSM120SKM11CT3AG device.

**Table 3 • Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
C <sub>iss</sub>	Input capacitance	V <sub>GS</sub> = 0 V			9060		pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 1000 V f = 1 MHz			810		
C <sub>rss</sub>	Reverse transfer capacitance				75		
Qg	Total gate charge	V <sub>GS</sub> = -5 V/20 V			696		nC
Q <sub>gs</sub>	Gate-source charge	$V_{Bus} = 800 \text{ V}$ $I_D = 120 \text{ A}$			123		
Q <sub>gd</sub>	Gate-drain charge				150		
T <sub>d(on)</sub>	Turn-on delay time	V <sub>GS</sub> = -5 V/20 V			30		ns
T <sub>r</sub>	Rise time	$V_{Bus} = 600 \text{ V}$ $I_D = 150 \text{ A}$			30		
T <sub>d(off)</sub>	Turn-off delay time	$R_{Gon}$ = 2.7 Ω; $R_{Goff}$ = 1.6 Ω			50		
T <sub>f</sub>	Fall time				25		
E <sub>on</sub>	Turn on energy	Inductive switching	T <sub>J</sub> = 150 °C		3		mJ
E <sub>off</sub>	Turn off energy	$V_{GS} = -5 \text{ V/20 V}$ $V_{Bus} = 600 \text{ V}$ $I_D = 150 \text{ A}$ $R_{Gon} = 2.7 \Omega$ $R_{Goff} = 1.6 \Omega$			2		mJ
R <sub>Gint</sub>	Internal gate resistance				2		Ω
R <sub>thJC</sub>	Junction-to-case thermal resistance					0.141	°C/W

The following table shows the body diode ratings and characteristics per MOSFET of the MSCSM120SKM11CT3AG device.

**Table 4 • Body Diode Ratings and Characteristics** 

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V <sub>SD</sub>	Diode forward voltage	V <sub>GS</sub> = 0 V; I <sub>SD</sub> = 120 A		4.0		V
		V <sub>GS</sub> = -5 V; I <sub>SD</sub> = 120 A		4.2		
t <sub>rr</sub>	Reverse recovery time	$I_{SD}$ = 120 A; $V_{GS}$ = -5 V $V_{R}$ = 800 V; $d_{iF}/dt$ = 3000 A/ $\mu$ s		90		ns
Q <sub>rr</sub>	Reverse recovery charge			1650		nC
I <sub>rr</sub>	Reverse recovery current			40.5		Α



## 3.2 SiC Scottky Diode Ratings and Characteristics

The following table shows the SiC Scottky diode ratings and characteristics per SiC diode of the MSCSM120SKM11CT3AG device.

**Table 5 • SiC Schottky Diode Ratings and Characteristics** 

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Peak repetitive reverse voltage					1200	V
I <sub>RM</sub>	Reverse leakage current	V <sub>R</sub> = 1200 V	T <sub>J</sub> = 25 °C		60	1200	μΑ
			T <sub>J</sub> = 175 °C		900		
I <sub>F</sub>	DC forward current		T <sub>C</sub> = 100 °C		180		А
V <sub>F</sub>	Diode forward voltage	I <sub>F</sub> = 180 A	T <sub>J</sub> = 25 °C		1.5	1.8	V
			T <sub>J</sub> = 175 °C		2.1		
Qc	Total capacitive charge	V <sub>R</sub> = 600 V			780		nC
С	Total capacitance	f = 1 MHz, V <sub>R</sub> = 400 V			846		pF
		f = 1 MHz, V <sub>R</sub> = 800 V			630		
R <sub>thJC</sub>	Junction-to-case thermal resistance					0.175	°C/W

## 3.3 Thermal and Package Characteristics

The following table shows the package characteristics of the MSCSM120SKM11CT3AG device.

**Table 6 • Package Characteristics** 

Symbol	Characteristic				Max	Unit
V <sub>ISOL</sub>	RMS isolation voltage, any terminal to case t = 1 min, 50 Hz/60 Hz					V
Тј	Operating junction temperature range				175	°C
T <sub>JOP</sub>	Recommended junction temperature under switching conditions			-40	T <sub>Jmax</sub> -25	
T <sub>STG</sub>	Storage temperature range			-40	125	
T <sub>C</sub>	Operating case temperature			-40	125	
Torque	Mounting torque To heatsink M4				3	N.m
Wt	Package weight				110	g



The following table shows the temperature sensor NTC (see application note *APT0406* on www.microsemi.com) of the MSCSM120SKM11CT3AG device.

**Table 7 • Temperature Sensor NTC** 

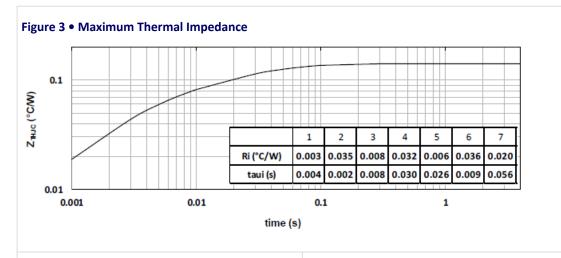
Symbol	Characteristic		Min	Тур	Max	Unit
R <sub>25</sub>	Resistance at 25 °C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K			3952		К
ΔΒ/Β		T <sub>C</sub> = 100 °C		4		%

$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature } \\ R_T: \text{ Thermistor value at T}$$



#### **Typical SiC MOSFET Performance Curves** 3.4

This sections shows the typical SiC MOSFET performance curves of the MSCSM120SKM11CT3AG device.



Output Characteristics 300 250

Figure 4 • Output Characteristics, T<sub>1</sub> = 25 °C

lg, Drain Source Current (A) 200 <sub>cs</sub>=20V VGS=18V 150 100 50 T<sub>J</sub>=25°C 1.0 1.5 2.5 3.0 0.0 V<sub>DS</sub>, Drain Source Voltage (V)

Figure 5 ● Output Characteristics, T<sub>J</sub> = 175 °C

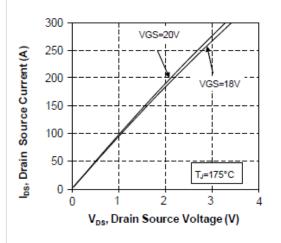


Figure 6 ● Normalized R<sub>DS(on)</sub> vs. Temperature Normalized RDS(on) vs. Temperature 1.6

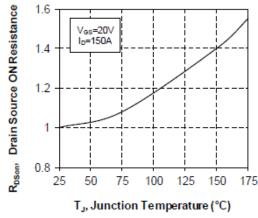
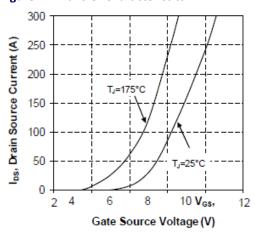


Figure 7 • Transfer Characteristics





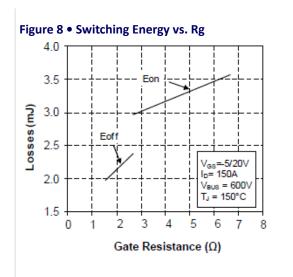
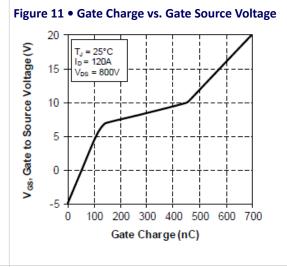
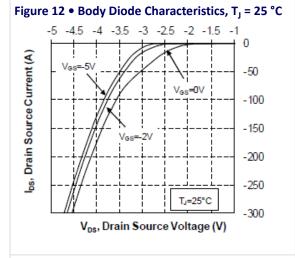


Figure 9 • Switching Energy vs. Current 6 5 Eon =2.7Ω  $R_{Goff}=1.6\Omega$ V<sub>BUS</sub>= 600V Losses (mJ) T<sub>J</sub> = 150°C 3 2 Eoff 0 0 100 150 200 250 300 50 Current (A)

Figure 10 • Capacitance vs. Drain Source Voltage 100000 C, Capacitance (pF) 10000 Ciss 1000 Coss 100 Crss 10 400 600 800 200 1000 V<sub>DS</sub>, Drain Source Voltage (V)





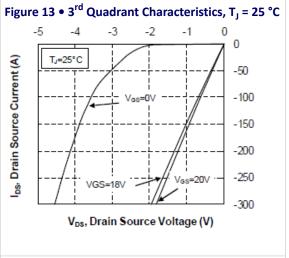
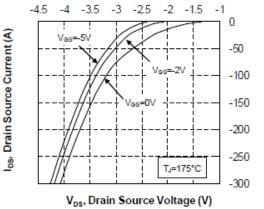




Figure 14 • Body Diode Characteristics, T<sub>J</sub> = 175 °C Figure 15 • 3<sup>rd</sup> Quadrant Characteristics, T<sub>J</sub> = 175 °C °C



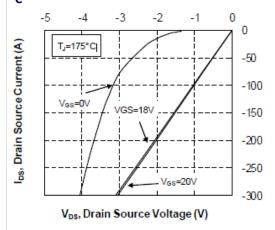
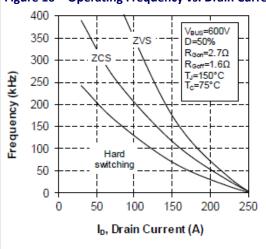


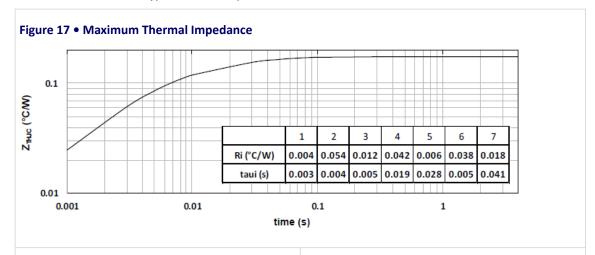
Figure 16 • Operating Frequency vs. Drain Current

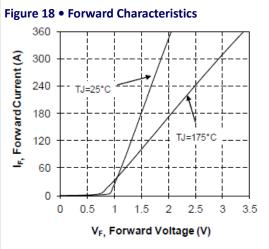


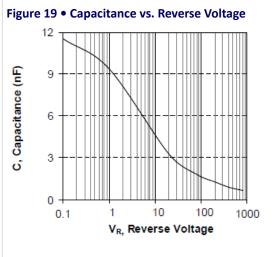


## 3.5 Typical SiC Diode Performance Curves

This sections shows the typical SiC diode performance curves of the MSCSM120SKM11CT3AG device.









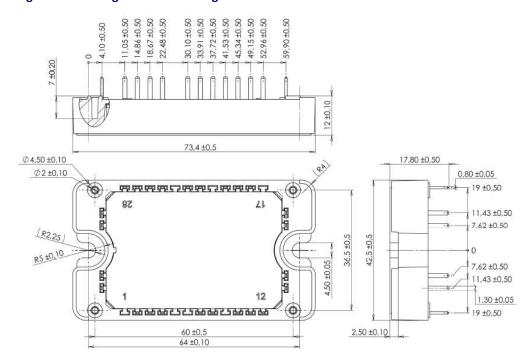
# 4 Package Specifications

This section shows the package specification of the MSCSM120SKM11CT3AG device.

#### 4.1 Package Outline Drawing

The following figure illustrates the package outline of the MSCSM120SKM11CT3AG device. The dimensions are in millimeters.

Figure 20 • Package Outline Drawing



**Note:** See application note *1906—Mounting Instructions for SP3F Power Modules* on www.microsemi.com





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